

**IN THE UNITED STATES PATENT AND TRADEMARK OFFICE**

Applicant(s): SHIMAZU et al

Serial No.:

Filed: January 22, 2004

For: Semiconductor Device And Its Production Process

**REAFFIRMATION OF CLAIM FOR PRIORITY**

Mail Stop: Application  
Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

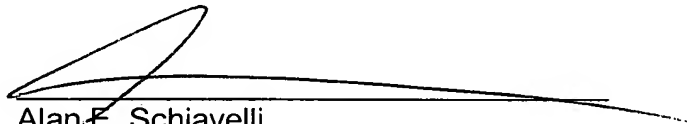
January 22, 2004

Sir:

Under the provisions of 35 USC §119 and 37 CFR §1.55, Applicants hereby claim the right of priority based on Japanese Patent Application No. Japanese Application No. 10-267695, filed in Japan on September 22, 1998.

The certified copy of the above-referred to Japanese Patent Application was received by the International Bureau in prior application Serial No. 09/787,743, filed June 8, 2001.

Respectfully submitted,



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FORM PTO-1449 U.S. Department of Commerce  
(Rev. 4/92) Patent and Trademark Office

**INFORMATION DISCLOSURE  
STATEMENT BY APPLICANT**

(Use several sheets if necessary)

ATTY. DOCKET NO.

500.39907VX1

SERIAL NO.

APPLICANT

SHIMAZU et al

FILING DATE

January 22, 2004

GROUP

**U.S. PATENT DOCUMENTS**

EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
	5 8 9 7 3 4 8	4/99	Wu			
	6 2 9 4 4 2 0	9/01	Tsu			

**FOREIGN PATENT DOCUMENTS**

DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION
					YES NO
2 8 6 0 6 2	1/91	Germany			
9 1 3 9 4 7 5	5/97	Japan			
3 2 4 8 5 6 2	11/91	Japan			
6 2 9 2 8 8	2/94	Japan			
60 2 1 3 0 5 8	10/85	Japan			
3 1 6 6 7 3 5	7/91	Japan			

**OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)**

	Mo et al "Formation and Properties of Ternary Silicide (CoNi)Si <sub>2</sub> Thin Films, IEEE 1998 5th International Conference on Solid State And Integrated Circuit Technology pp 271-274
	Hong et al "Magneto-Optic Kerr Effect Measurements on FeCoSi Epitaxially Stabilized on Si (111), Journal of Magnetism and Magnetic Materials, vol. 165 pp 212-215
	<a href="http://www.puretechnic.com">http://www.puretechnic.com</a> and <a href="http://tosohsmd.com/tsprod.tspcobdt.htm">http://tosohsmd.com/tsprod.tspcobdt.htm</a> , Material Data Sheet MDS 27.000 which includes the total metallics of the cobalt target, pp 1-4 and 1-3

EXAMINER

DATE CONSIDERED

EXAMINER: Initial if citation is considered, draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.



